	e for form 1449A		5, no persons a	are required to respond to a collection of	of information unless it contains a valid OMB control number.	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT			JRE		Complete if Known	
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				First Named Inventor	WILLIS, Colin	
				Art Unit	1792	
				Examiner Name	Padgett, Marianne	
(Use as many sheets as necessary)						
Sheet	1	of	1	Attorney Docket No: 41577-266144		

	U.S. PATENT DOCUMENTS					
Examiner Initials *	Cite No <sup>1</sup>	Document Number Number-Kind Code <sup>2</sup>	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	

FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No	Foreign Patent Document Country Code <sup>3</sup> Number <sup>4</sup> Kind Code <sup>5</sup>	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>	

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
		Panchalingam, et al., 'Molecular Tailoring of Surfaces via Pulsed RF Plasma Depositions,' J. Biomater. Sci. Polymer Edn, 5(1/2):131-145 (1993)	
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	Wang, et al., 'Plasma Synthesis of a Novel CF <sub>3</sub> -Dominated Fluorocarbon Film,' Chem. Mater., 8:2212-2214 (1996)		

**EXAMINER DATE CONSIDERED**